



2133

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| AMENDMENT TRANSMITTAL LETTER                          |                                 |                            | Docket No.<br>SON-2313 |  |
|---|---------------------------------|----------------------------|------------------------|--|
| Application No.<br>10/052,736-Conf. #3283             | Filing Date<br>January 23, 2002 | Examiner<br>J. C. Kerveros | Art Unit<br>2133       |  |
| Applicant(s): Satoshi Ikeda                           |                                 |                            |                        |  |
| Invention: SEMICONDUCTOR TESTING APPARATUS AND METHOD |                                 |                            |                        |  |

**TO THE COMMISSIONER FOR PATENTS**

Transmitted herewith is an amendment in the above-identified application.

The fee has been calculated and is transmitted as shown below.

| CLAIMS AS AMENDED  |   |   |                                   |         |        |
|--|---|---|-----------------------------------|---------|--------|
|  | Claims<br>Remaining<br>After<br>Amendment | Highest<br>Number<br>Previously<br>Paid | Number<br>Extra Claims<br>Present | Rate    |        |
| Total Claims   | 28  | - 20 =                                  | 8                                 | x 18.00 | 144.00 |
| Independent<br>Claims  | 3   | - 3 =                                   |                                   | x       |        |
| Multiple Dependent Claims (check if applicable) <input type="checkbox"/> |   |   |                                   |         |        |
| Other fee (please specify):  |   |   |                                   |         |        |
| TOTAL ADDITIONAL FEE FOR THIS AMENDMENT:                                 |   |   |                                   |         | 144.00 |

☒ Large Entity

☐ Small Entity

☐ No additional fee is required for this amendment.

☒ Please charge Deposit Account No. 18-0013 in the amount of \$ 144.00.

A duplicate copy of this sheet is enclosed.

☐ A check in the amount of \$ \_\_\_\_\_ to cover the filing fee is enclosed.

☐ Payment by credit card. Form PTO-2038 is attached.

☒ The Director is hereby authorized to charge and credit Deposit Account No. 18-0013 as described below. A duplicate copy of this sheet is enclosed.

☒ Credit any overpayment.

☒ Charge any additional filing or application processing fees required under 37 CFR 1.16 and 1.17.

Dated: September 2, 2004

Ronald P. Kananen  
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Docket No.: SON-2313  
(PATENT)

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Patent Application of:  
Satoshi Ikeda

Confirmation No.: 3283

Application No.: 10/052,736

Art Unit: 2858

Filed: January 23, 2002

Examiner: J. C. Kerveros

For: SEMICONDUCTOR TESTING APPARATUS  
AND METHOD

**AMENDMENT IN RESPONSE TO NON-FINAL OFFICE ACTION**

MS Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

**INTRODUCTORY COMMENTS**

In response to the Office Action dated June 2, 2004, please amend the above-identified U.S. patent application as follows:

**Amendments to the Specification** begin on page 2 of this paper.

**Amendments to the Claims** are reflected in the listing of claims which begins on page 3 of this paper.

**Amendments to the Abstract** begin on page 10 of this paper.

**Remarks/Arguments** begin on page 11 of this paper.

An **Appendix** including the Abstract on a separate sheet is attached following page

19 of this paper.

09/03/2004 BABRAHA1 00000133 180013 10052736

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